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National Semiconductor

MICROCIRCUIT DATA SHEET

MJLM101A-X REV 0A0

Original Creation Date: 06/21/95
Last Update Date: 03/28/00
Last Major Revision Date: 01/19/00

SINGLE OPERATIONAL AMPLIFIER - EXTERNALLY COMPENSATED

General Description

The LM101A is a general purpose operational amplifier which features improved performance over industry standards such as the LM709. Advanced processing techniques make possible an order of magnitude reduction in input currents, and a redesign of the biasing circuitry reduces the temperature drift of input current.

This amplifier offers many features which make its application nearly foolproof: overload protection on the input and output, no latch-up when the common mode range is exceeded, and freedom from oscillations and compensation with a single 30 pF capacitor. It has advantages over internally compensated amplifiers in that the frequency compensation can be tailored to the particular application. For example, in low frequency circuits it can be overcompensated for increased stability margin. Or the compensation can be optimized to give more than a factor of ten improvement in high frequency performance for most applications.

In addition, the device provides better accuracy and lower noise in high impedance circuitry. The low input currents also make it particularly well suited for long interval integrators or timers, sample and hold circuits and low frequency waveform generators. Further, replacing circuits where matched transistor pairs buffer the inputs of conventional IC op amps, it can give lower offset voltage and a drift at a lower cost.

Industry Part Number

LM101A

Prime Die

LM101A

Controlling Document

38510/10103,AMEND.2 CIR.G REV G

NS Part Numbers

JL101ABCA
JL101ABGA
JL101ABHA
JL101ABPA
JL101ASCA
JL101ASGA
JL101ASHA
JL101ASPA

Processing

MIL-STD-883, Method 5004

Quality Conformance Inspection

MIL-STD-883, Method 5005

Subgrp	Description	Temp (^{O}C)
1	Static tests at	+25
2	Static tests at	+125
3	Static tests at	-55
4	Dynamic tests at	+25
5	Dynamic tests at	+125
6	Dynamic tests at	-55
7	Functional tests at	+25
8A	Functional tests at	+125
8B	Functional tests at	-55
9	Switching tests at	+25
10	Switching tests at	+125
11	Switching tests at	-55

Features

- Offset voltage 3 mV maximum over temperature
- Input current 100 nA maximum over temperature
- Offset current 20 nA maximum over temperature
- Guaranteed drift characteristics
- Offsets guaranteed over entire common mode and supply voltage ranges
- Slew rate of 10V/us as a summing amplifier

(Absolute Maximum Ratings)
(Note 1)

Supply Voltage	±22V
Differential Input Voltage	±30V
Input Voltage (Note 3)	±15V
Ouput Short Circuit Duration (Note 2)	Continuous
Operating Ambient Temp. Range	-55 C to +125 C
Maximum Junction Temperature	150 C
Power Dissipation at TA = 25 C (Note 2)	
H-Pkg (Still Air)	750mW
H-Pkg (500LF/Min Air Flow)	1200mW
J8-Pkg (Still Air)	1000mW
J8-Pkg (500LF/Min Air Flow)	1500mW
J14-Pkg (Still Air)	1200mW
J14-Pkg (500LF/Min Air Flow)	2000mW
W-Pkg (Still Air)	500mW
W-Pkg (500LF/Min Air Flow)	800mW
Thermal Resistance ThetaJA	
H-Pkg (Still Air)	165 C/W
H-Pkg (500LF/Min Air Flow)	89 C/W
J8-Pkg (Still Air)	128 C/W
J8-Pkg (500LF/Min Air Flow)	75 C/W
J14-Pkg (Still Air)	98 C/W
J14-Pkg (500LF/Min Air Flow)	59 C/W
W-Pkg (Still Air)	233 C/W
W-Pkg (500LF/Min Air Flow)	155 C/W
ThetaJC	
H-Pkg	39 C/W
J8-Pkg	26 C/W
J14-Pkg	24 C/W
W-Pkg	26 C/W
Storage Temperature Range	-65 C to +150 C
Lead Temperature (Soldering, 10 seconds)	300 C
ESD Tolerance (Note 4)	2000V

Note 1: Absolute Maximum Ratings indicate limits beyond which damage to the device may occur. Operating Ratings indicate conditions for which the device is intended to be functional, but do not guarantee specific performance limits. For guaranteed specifications and test conditions, see the Electrical Characteristics. The guaranteed specifications apply only for the test conditions listed. Some performance characteristics may degrade when the device is not operated under the listed test conditions.

Note 2: The maximum power dissipation must be derated at elevated temperatures and is dictated by Tjmax (maximum junction temperature), ThetaJA (package junction to ambient thermal resistance), and TA (ambient temperature). The maximum allowable power dissipation at any temperature is Pdmax = (Tjmax - TA)/ThetaJA or the number given in the Absolute Maximum Ratings, whichever is lower.

Note 3: For supply voltages less than ±15V, the absolute maximum input voltage is equal to the supply voltage.

Note 4: Human body model, 100 pF discharged through 1.5k Ohms.

Electrical Characteristics

DC PARAMETERS

(The following conditions apply to all the following parameters, unless otherwise specified.)
DC: ±Vcc = ±20V, Vcm = 0V, Rs = 50 ohms

SYMBOL	PARAMETER	CONDITIONS	NOTES	PIN-NAME	MIN	MAX	UNIT	SUB-GROUPS
Vio	Input Offset Voltage	+Vcc = 35V, -Vcc = -5V, Vcm = -15V			-2	+2	mV	1
					-3	+3	mV	2, 3
		+Vcc = 5V, -Vcc = -35V, Vcm = +15V			-2	+2	mV	1
					-3	+3	mV	2, 3
		Vcm = 0V			-2	+2	mV	1
					-3	+3	mV	2, 3
		+Vcc = 5V, -Vcc = -5V, Vcm = 0V			-2	+2	mV	1
					-3	+3	mV	2, 3
Iio	Input Offset Current	+Vcc = 35V, -Vcc = -5V, Vcm = -15V, Rs = 100K Ohms			-10	+10	nA	1, 2
					-20	+20	nA	3
		+Vcc = 5V, -Vcc = -35V, Vcm = +15V, Rs = 100K Ohms			-10	+10	nA	1, 2
					-20	+20	nA	3
		Vcm = 0V, Rs = 100K Ohms			-10	+10	nA	1, 2
					-20	+20	nA	3
		+Vcc = 5V, -Vcc = -5V, Vcm = 0V, Rs = 100K Ohms			-10	+10	nA	1, 2
					-20	+20	nA	3
Iib+	Input Bias Current	+Vcc = 35V, -Vcc = -5V, Vcm = -15V, Rs = 100K Ohms			-0.1	75	nA	1, 2
					-0.1	100	nA	3
		+Vcc = 5V, -Vcc = -35V, Vcm = +15V, Rs = 100K Ohms			-0.1	75	nA	1, 2
					-0.1	100	nA	3
		Vcm = 0V, Rs = 100K Ohms			-0.1	75	nA	1, 2
					-0.1	100	nA	3
		+Vcc = 5V, -Vcc = -5V, Vcm = 0V, Rs = 100K Ohms			-0.1	75	nA	1, 2
					-0.1	100	nA	3

Electrical Characteristics

DC PARAMETERS(Continued)

(The following conditions apply to all the following parameters, unless otherwise specified.)
DC: ±Vcc = ±20V, Vcm = 0V, Rs = 50 ohms

SYMBOL	PARAMETER	CONDITIONS	NOTES	PIN-NAME	MIN	MAX	UNIT	SUB-GROUPS
Iib-	Input Bias Current	+Vcc = 35V, -Vcc = -5V, Vcm = -15V, Rs = 100K Ohms			-0.1	75	nA	1, 2
					-0.1	100	nA	3
		+Vcc = 5V, -Vcc = -35V, Vcm = +15V, Rs = 100K Ohms			-0.1	75	nA	1, 2
					-0.1	100	nA	3
		Vcm = 0V, Rs = 100K Ohms			-0.1	75	nA	1, 2
					-0.1	100	nA	3
		+Vcc = 5V, -Vcc = -5V, Vcm = 0V, Rs = 100K Ohms			-0.1	75	nA	1, 2
					-0.1	100	nA	3
+PSRR	Power Supply Rejection Ratio	+Vcc = 10V, -Vcc = -20V			-50	+50	uV/V	1
					-100	+100	uV/V	2, 3
-PSRR	Power Supply Rejection Ratio	+Vcc = 20V, -Vcc = -10V			-50	+50	uV/V	1
					-100	+100	uV/V	2, 3
CMRR	Common Mode Rejection Ratio	Vcc = ±35V to ±5V, Vcm = ±15V			80		dB	1, 2, 3
VioADJ(+)	Adjustment for Input Offset Voltage				4		mV	1, 2, 3
VioADJ(-)	Adjustment for Input Offset Voltage					-4	mV	1, 2, 3
Ios+	Output Short Circuit Current	+Vcc = 15V, -Vcc = -15V, t ≤ 25mS, Vcm = -15V			-60		mA	1, 2, 3
Ios-	Output Short Circuit Current	+Vcc = 15V, -Vcc = -15V, t ≤25mS, Vcm = +15V				+60	mA	1, 2, 3
Icc	Power Supply Current	+Vcc = 15V, -Vcc = -15V				3	mA	1
						2.32	mA	2
						3.5	mA	3
Delta Vio/Delta T	Temperature Coefficient of Input Offset Voltage	+25 C ≤ TA ≤ +125 C	1		-15	+15	uV/ C	2
		+25 C ≤ TA ≤ -55 C	1		-18	+18	uV/ C	3
Delta Iio/Delta T	Temperature Coefficient of Input Offset Current	+25 C ≤ TA ≤ +125 C	1		-100	+100	pA/ C	2
		+25 C ≤ TA ≤ -55 C	1		-200	+200	pA/ C	3

Electrical Characteristics

DC PARAMETERS(Continued)

(The following conditions apply to all the following parameters, unless otherwise specified.)
DC: ±Vcc = ±20V, Vcm = 0V, Rs = 50 ohms

SYMBOL	PARAMETER	CONDITIONS	NOTES	PIN-NAME	MIN	MAX	UNIT	SUB-GROUPS
Avs-	Large Signal (Open Loop) Voltage Gain	Rl = 2K Ohms, Vout = -15V	2		50		V/mV	4
			2		25		V/mV	5, 6
		Rl = 10K Ohms, Vout = -15V	2		50		V/mV	4
			2		25		V/mV	5, 6
Avs+	Large Signal (Open Loop) Voltage Gain	Rl = 2K Ohms, Vout = +15V	2		50		V/mV	4
			2		25		V/mV	5, 6
		Rl = 10K Ohms, Vout = +15V	2		50		V/mV	4
			2		25		V/mV	5, 6
Avs	Large Signal (Open Loop) Voltage Gain	Vcc = ±5V, Rl = 2K Ohms, Vout = ±2V	2		10		V/mV	4, 5, 6
		Vcc = ±5V, Rl = 10K Ohms, Vout = ±2V	2		10		V/mV	4, 5, 6
Vop+	Output Voltage Swing	Rl = 10K Ohms, Vcm = -20V			+16		V	4, 5, 6
		Rl = 2K Ohms, Vcm = -20V			+15		V	4, 5, 6
Vop-	Output Voltage Swing	Rl = 10K Ohms, Vcm = 20V				-16	V	4, 5, 6
		Rl = 2K ohms, Vcm = 20V				-15	V	4, 5, 6

AC PARAMETERS

(The following conditions apply to all the following parameters, unless otherwise specified.)
AC: ±Vcc = ±20V, Vcm = 0V, Rs = 50 Ohms

Sr+	Slew Rate	Av = 1, Vin = -5V to +5V			0.3		V/uS	7, 8A
					0.2		V/uS	8B
Sr-	Slew Rate	Av = 1, Vin = +5V to -5V			0.3		V/uS	7, 8A
					0.2		V/uS	8B
TR(tr)	Rise Time	Av = 1, Vin = 50mV				800	nS	7, 8A, 8B
TR(os)	Overshoot	Av = 1, Vin = 50mV				25	%	7, 8A, 8B
NI(BB)	Noise Broadband	BW = 10Hz to 5KHz, Rs = 0 Ohms				15	uVrms	7
NI(PC)	Noise Popcorn	BW = 10Hz to 5KHz, Rs = 100K Ohms				80	uVpk	7

Electrical Characteristics

DC PARAMETERS: DRIFT VALUES

(The following conditions apply to all the following parameters, unless otherwise specified.)
DC: ±Vcc = ±20V, Vcm = 0V, Rs = 50 Ohms. "Delta calculations performed on JAN S and QMLV devices at group B, subgroup 5 only".

SYMBOL	PARAMETER	CONDITIONS	NOTES	PIN-NAME	MIN	MAX	UNIT	SUB-GROUPS
Vio	Input Offset Voltage	Vcm = 0V			-0.5	0.5	mV	1
Iib+	Input Bias Current	Vcm = 0V, Rs = 100K Ohms			-7.5	7.5	nA	1
Iib-	Input Bias Current	Vcm = 0V, Rs = 100K Ohms			-7.5	7.5	nA	1

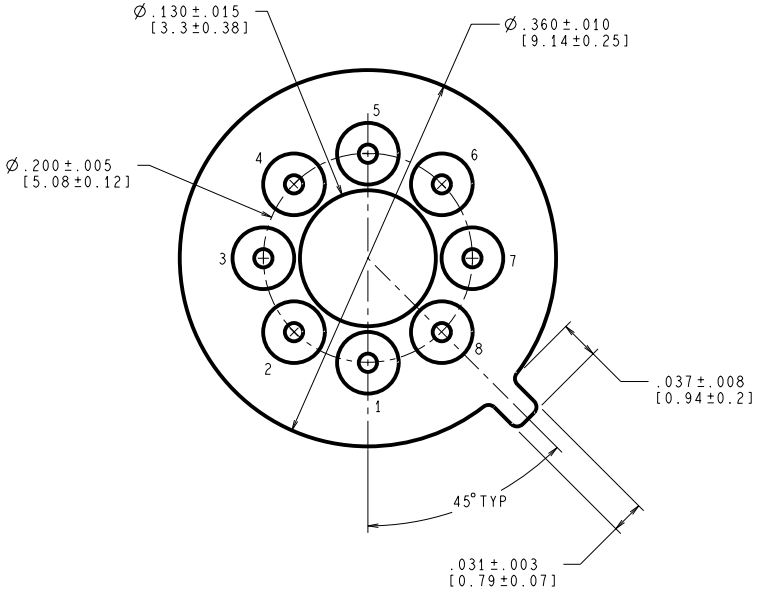
Note 1: Calculated parameter.
Note 2: Datalog reading of K = V/mV.

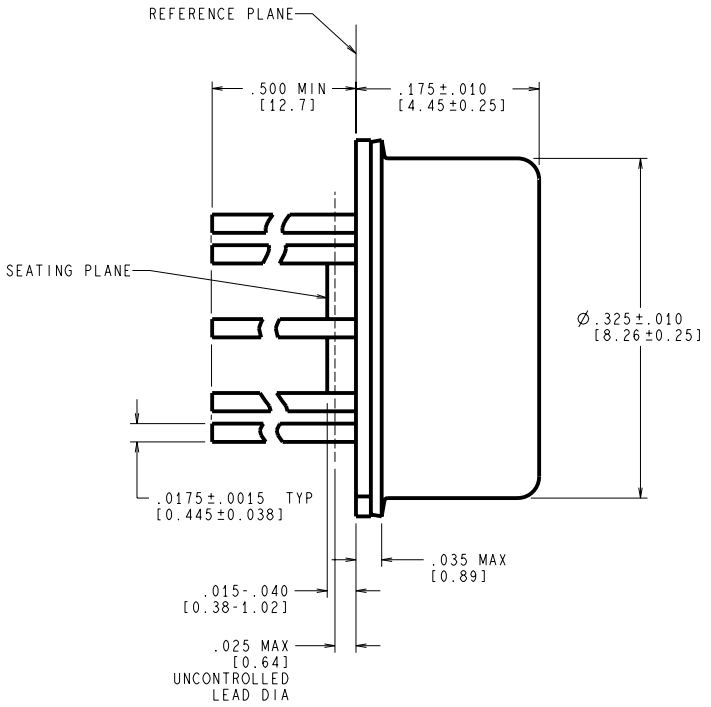
Graphics and Diagrams

GRAPHICS#	DESCRIPTION
05309HRB2	CERDIP (J), 14 LEAD (B/I CKT)
08337HRB2	CERPACK (W), 10 LEAD (B/I CKT)
09384HRA4	METAL CAN, (H) TO-99,8 LEAD,.200 DIA P.C.(B/I CKT)
09413HRB1	CERDIP (J), 8 LEAD (B/I CKT)
H08CRF	METAL CAN (H), TO-99, 8LD, .200 DIA P.C. (P/P DWG)
J08ARL	CERDIP (J), 8 LEAD (P/P DWG)
J14ARH	CERDIP (J), 14 LEAD (P/P DWG)
P000178A	METAL CAN (H), 8 LEAD (PINOUT)
P000180A	CERPACK (W), 10 LEAD (PINOUT)
P000226A	CERDIP (J), 8 LEAD (PINOUT)
P000227A	CERDIP (J), 14 LEAD (PINOUT)
W10ARG	CERPACK (W), 10 LEAD (P/P DWG)

See attached graphics following this page.

REVISIONS				
LTR	DESCRIPTION	E.C.N.	DATE	BY/APP'D
F	REVISE & REDRAW PER CURRENT STANDARD; UPDATE MIL/AERO STAMP & TITLE.	11002	06/22/95	MS/





CONTROLLING DIMENSION IS INCH
VALUES IN [] ARE MILLIMETERS

MIL-I-38535
CONFIGURATION CONTROL

NOTES: UNLESS OTHERWISE SPECIFIED

1. LEADS TO BE LOCATED WITHIN .007 IN/ 0.18 mm OF THEIR TRUE POSITIONS RELATIVE TO A MAXIMUM WIDTH TAB.
2. STANDARD METAL CAN TYPE: SOLID BASE WITH CERAMIC STANDOFF.
3. APPLIES TO MIL-AERO AND LINEAR PRODUCTS.
4. REFERENCE JEDEC REGISTRATION TO-99, JEDEC PUBLICATION No.95.

APPROVALS	DATE
DRAWN: MARTA SUCHY	06/22/95
DFTG. CHK.	
ENGR. CHK.	

National Semiconductor
2900 Semiconductor dr, Santa Clara, CA 95052-8090

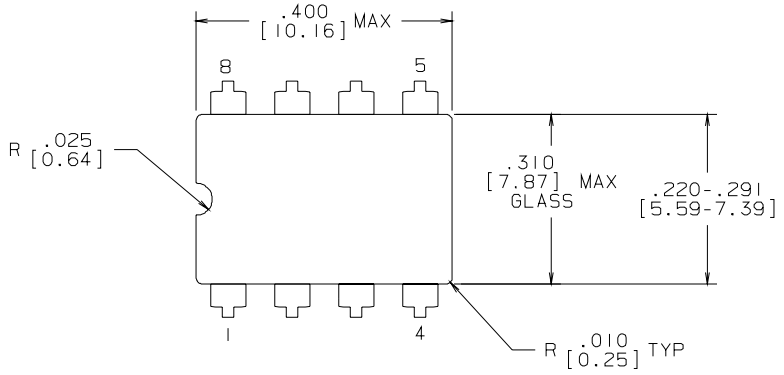
METAL CAN, TO-99, 8 LEAD, .200 DIA P.C.

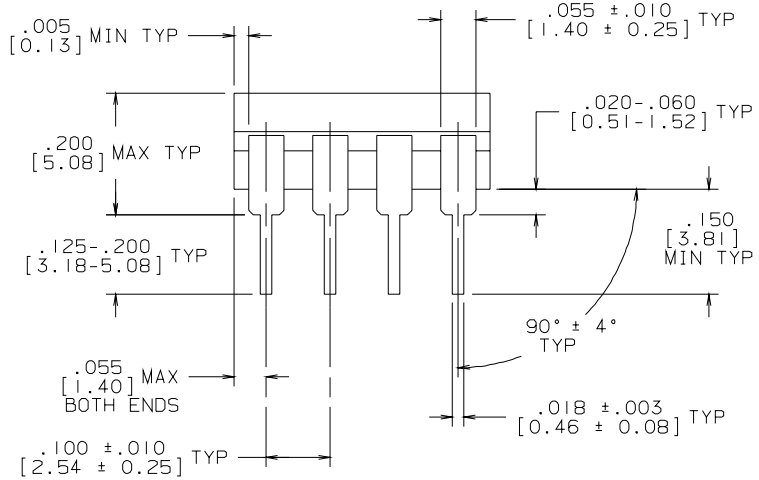
PROJECTION — INCH [MM]

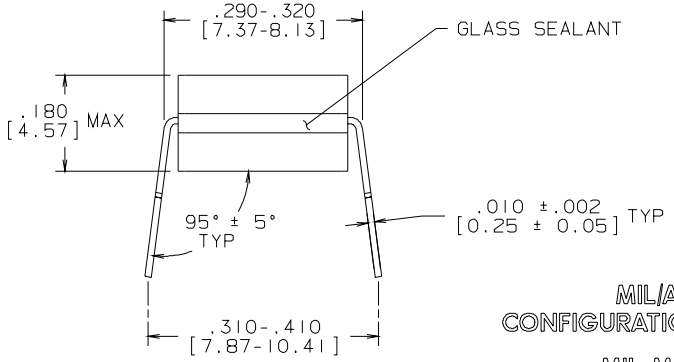
SCALE	SIZE	DRAWING NUMBER	REV
N/A	C	MKT-H08C	F

DO NOT SCALE DRAWING — SHEET 1 of 1

REVISIONS				
LTR	DESCRIPTION	E.C.N.	DATE	BY/APP'D
L	REVISE PER CURRENT STD; REDRAW	10002	09/21/93	TL/







MIL/AERO
CONFIGURATION CONTROL

MIL-M-38510
CONFIGURATION CONTROL

NOTES: UNLESS OTHERWISE SPECIFIED

1. LEAD FINISH TO BE 200 MICROINCHES / 5.08 MICROMETERS MINIMUM SOLDER MEASURED AT THE CREST OF THE MAJOR FLATS.
2. JEDEC REGISTRATION MO-036, VARIATION AA, DATED 04/1981.

CONTROLLING DIMENSION: INCH

APPROVALS	DATE
DRAWN T. LEQUANG	09/21/93
DFTG. CHK.	
ENGR. CHK.	
APPROVAL	

PROJECTION

INCH
[MM]

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CERDIP (J), 8 LEAD

SCALE	SIZE	DRAWING NUMBER	REV
N/A	B	MKT-J08A	L

DO NOT SCALE DRAWING | SHEET 1 OF 1

REVISIONS				
LTR	DESCRIPTION	E.C.N.	DATE	BY/APP'D
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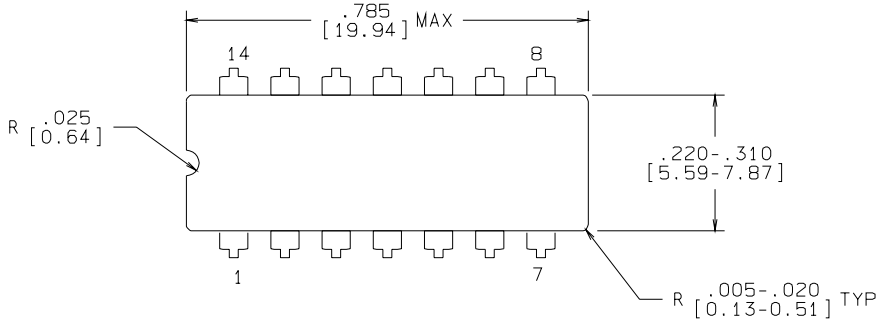

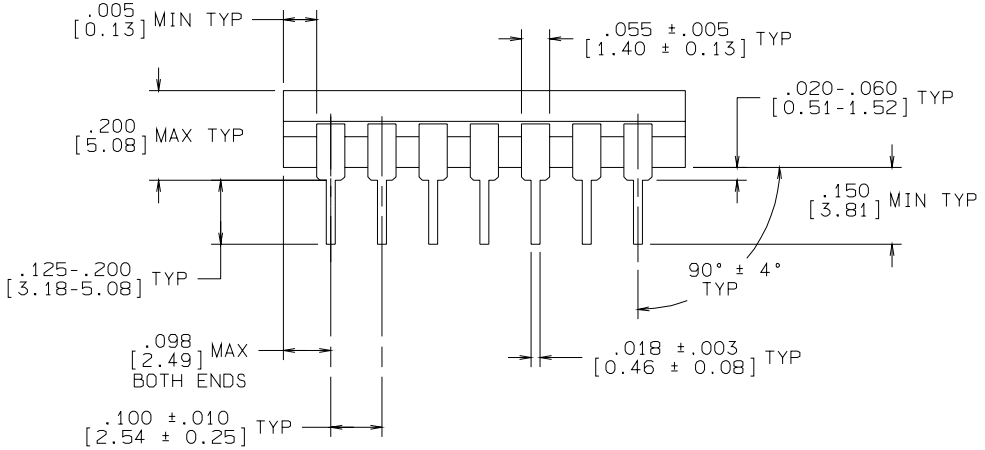

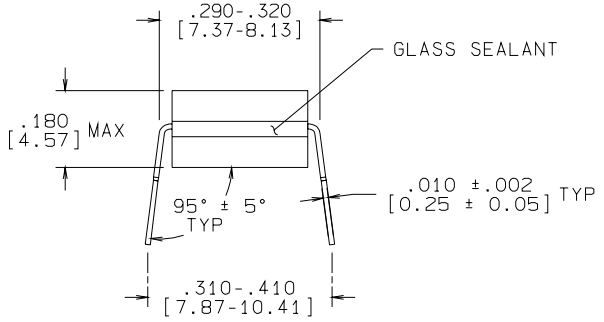

CONTROLLING DIMENSION: INCH

MIL/AERO CONFIGURATION CONTROL

MIL-M-38510 CONFIGURATION CONTROL

NOTES: UNLESS OTHERWISE SPECIFIED

1. LEAD FINISH TO BE 200 MICROINCHES / 5.08 MICROMETERS MINIMUM SOLDER MEASURED AT THE CREST OF THE MAJOR FLATS.
2. JEDEC REGISTRATION MO-036, VARIATION AB, DATED 04/1981.

APPROVALS	DATE
DRAWN T. LEQUANG	09/15/93
DFTG. CHK.	
ENGR. CHK.	
APPROVAL	

PROJECTION

INCH
[MM]

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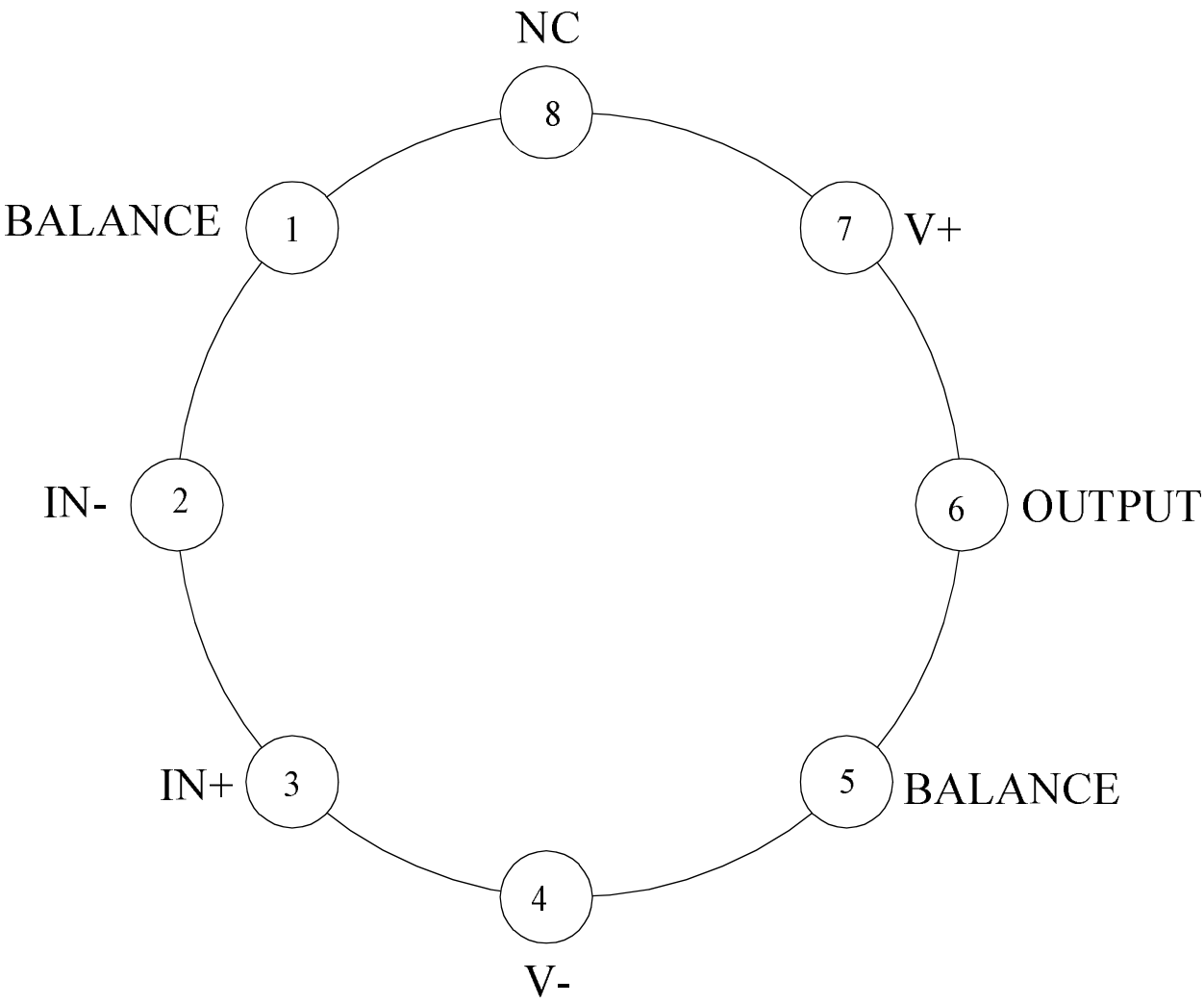
CERDIP (J), 14 LEAD,

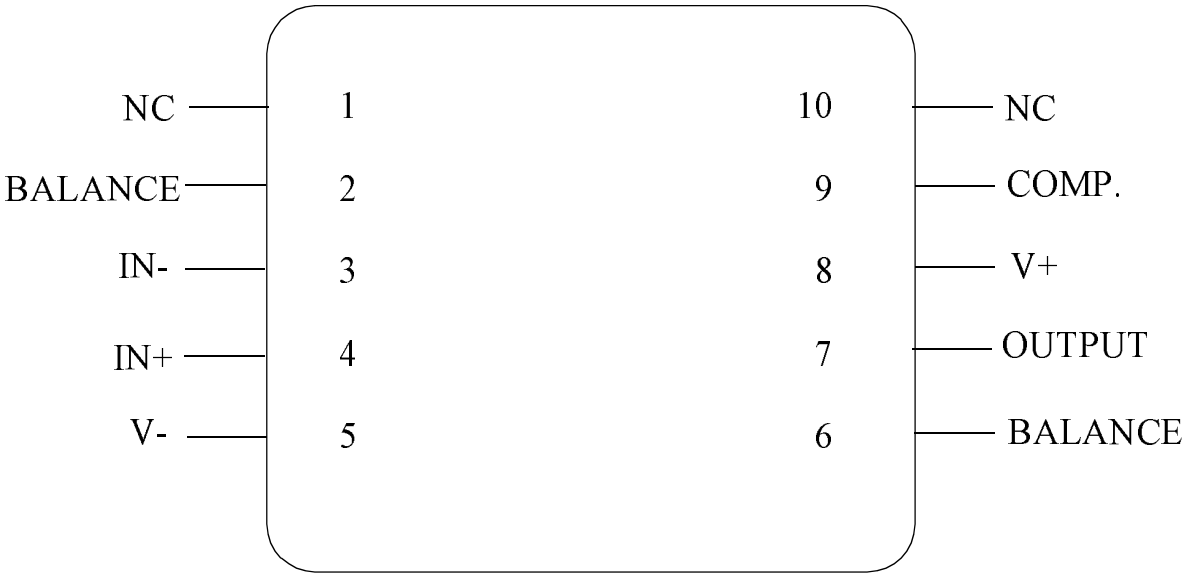
SCALE	SIZE	DRAWING NUMBER	REV
N/A	B	MKT-J14A	H

DO NOT SCALE DRAWING | SHEET 1 OF 1



LM101AH, LM101H
8 - PIN METAL CAN
CONNECTION DIAGRAM
TOP VIEW
P000178A

National Semiconductor™
MIL/AEROSPACE OPERATIONS
2900 SEMICONDUCTOR DRIVE
SANTA CLARA, CA 95050



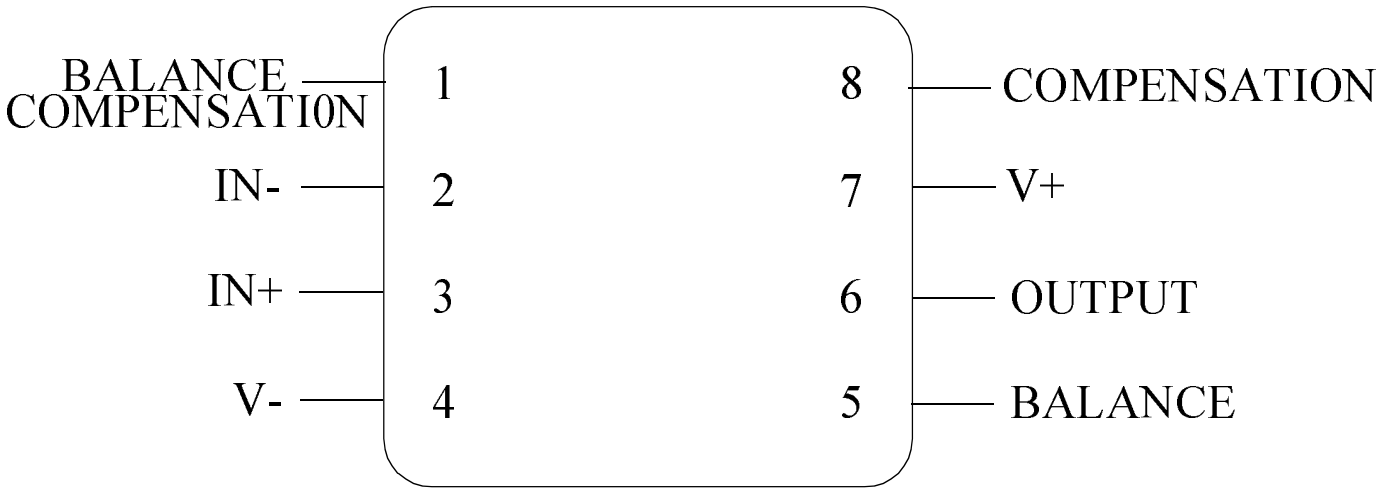
LM101AW

10 - LEAD CERPACK

CONNECTION DIAGRAM
TOP VIEW

P000180A

National Semiconductor™
MIL/AEROSPACE OPERATIONS
2900 SEMICONDUCTOR DRIVE
SANTA CLARA, CA 95050



LM101AJ, LM101J

8 - LEAD DIP

CONNECTION DIAGRAM

TOP VIEW

P000226A

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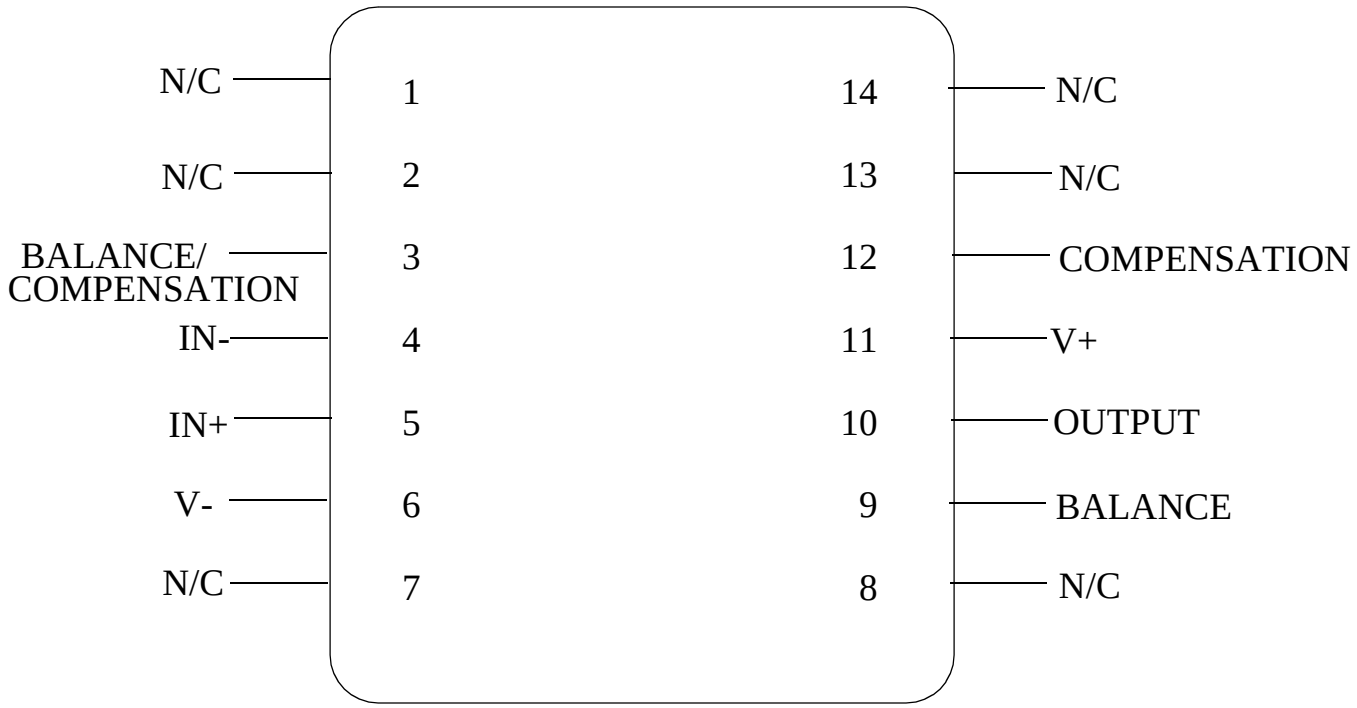
MIL/AEROSPACE OPERATIONS
2900 SEMICONDUCTOR DRIVE
SANTA CLARA, CA 95050



LM101AJ-14

14 - LEAD DIP

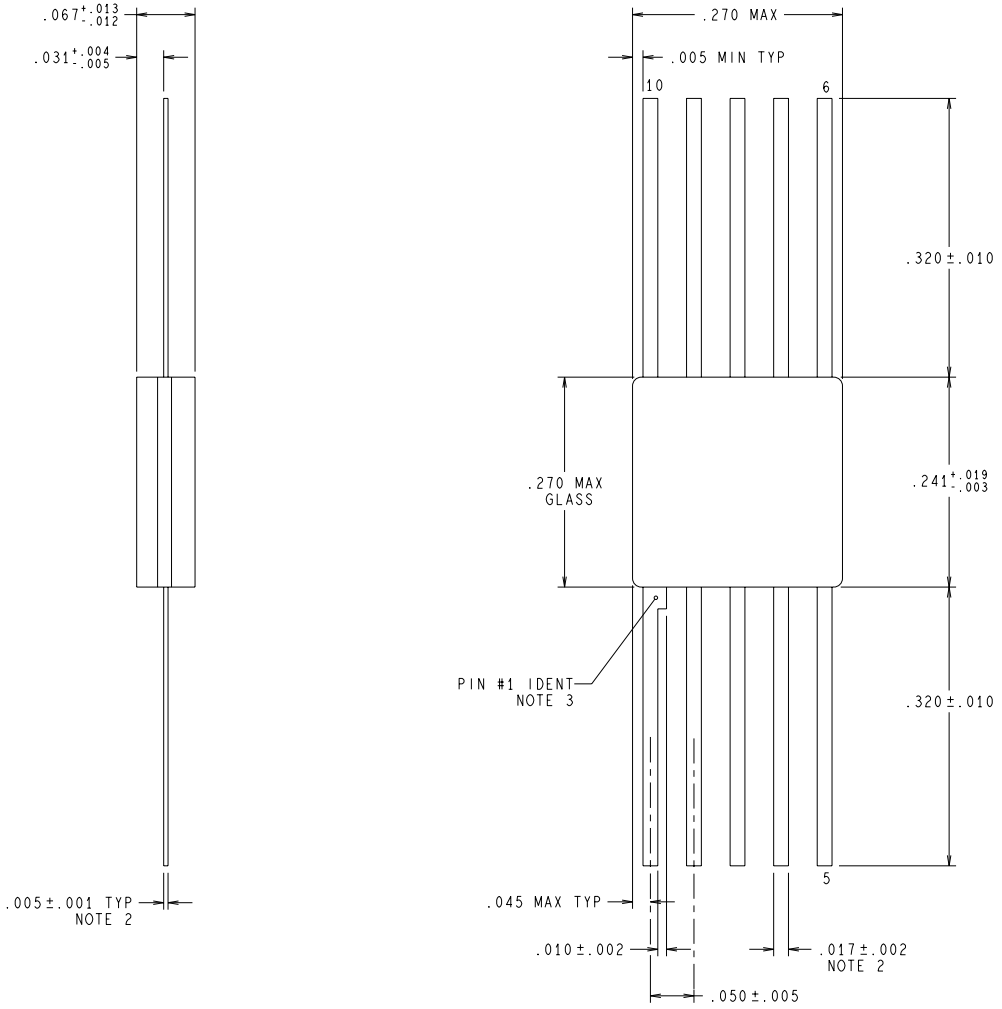
CONNECTION DIAGRAM

TOP VIEW

P000227A

National Semiconductor™
MIL/AEROSPACE OPERATIONS
2900 SEMICONDUCTOR DRIVE
SANTA CLARA, CA 95050

REVISIONS				
LTR	DESCRIPTION	E.C.N.	DATE	BY/APP'D
F	REVISE AND REDRAW PER NEW STANDARD.	10510	07/28/94	DEG/AEP
G	.017±.002 WAS .017±.020.	10654	10/21/94	DEG/



NOTES: UNLESS OTHERWISE SPECIFIED.

1. LEAD FINISH: SOLDER DIPPED WITH Sn60 OR Sn63 SOLDER CONFORMING TO MIL-M-38510 TO A MINIMUM THICKNESS OF 200 MICROINCHES. SOLDER MAY BE APPLIED OVER LEAD BASIS METAL OR Sn PLATE.
2. MAXIMUM LIMIT MAY BE INCREASED BY .003 INCHES AFTER LEAD FINISH APPLIED.
3. LEAD 1 IDENTIFICATION SHALL BE:
   a) A NOTCH OR OTHER MARK WITHIN THIS AREA
   b) A TAB ON LEAD 1, EITHER SIDE
4. REFERENCE JEDEC REGISTRATION MO-003, VARIATION AG, DATED 06/01/76.

MIL/AERO CONFIGURATION CONTROL

MIL-M-38510 CONFIGURATION CONTROL

APPROVALS	DATE
DRAWN: D.E.Grady	07/28/94
DFTG. CHK.	
ENGR. CHK.	

PROJECTION — INCH [MM]

National Semiconductor
2900 Semiconductor dr, Santa Clara, CA 95052-8090

CERPACK, 10 LEAD

SCALE	SIZE	DRAWING NUMBER	REV
N/A	C	MKT-W10A	G

DO NOT SCALE DRAWING — SHEET 1 of 1

Revision History

Rev	ECN #	Rel Date	Originator	Changes
0A0	M0003644	03/28/00	Rose Malone	Update MDS from MJLM101A-X, Rev. 0BL to a Fully Release MDS MJLM101A-X, Rev. 0A0. Added Genral Description, Features Section, Absolute Section. Updated Note Section.